


<b>Search Notes</b> 	<b>Application/Control No.</b> 10552494	<b>Applicant(s)/Patent Under Reexamination</b> ST-DENIS, YVES
	<b>Examiner</b> Jaisle, Cecilia M	<b>Art Unit</b> 1624

SEARCHED			
Class	Subclass	Date	Examiner
514	222.5, 252.04, 255.05, 269	10/19/2007	Cecilia Jaisle
544	8, 238, 279	10/19/2007	Cecilia Jaisle

SEARCH NOTES		
Search Notes	Date	Examiner
STN and Inventor Names searched by STIC	10/19/2007	Cecilia Jaisle

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner